



Accreditations:



APEC TEL CA0001



3000 Bristol Circle,
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Tel.: (905) 829-1570
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Website: www.ultratech-labs.com

January 8, 2025

Elprotronic Inc.
35 Austin Rumble Court
King City, Ontario
Canada, L7B 0B2

Attn.: **Mr. Gregory Czajkowski**
Subject: **Verification Testing under ISED CANADA ICES-003, ISSUE 7, Class A - Information Technology Equipment (Including Digital Apparatus).**
Product: **Universal Gang Programmer**
Model No.: **S-GANG-Is0**

Dear Mr. Czajkowski,

The product sample, as provided by you, has been tested and found to comply with **ISED Canada ICES-003, Issue 7, Class A - Information Technology Equipment (Including Digital Apparatus)**, the compliance is suggested by ISED Canada as follows:

CAN ICES-3 (B)/NMB-3(B)

Enclosed you will find a copy of the engineering report. If you have any queries, please do not hesitate to contact us.

Yours truly,

Tri Minh Luu
V.P., Engineering

Encl

VERIFICATION CERTIFICATE



NOT TRANSFERABLE

This Verification Certificate is hereby issued to the named GRANTEE and is VALID ONLY for the equipment identified hereon for use under the rules and regulations listed below:

GRANTEE:

Address: **Elprotronic Inc**
35 Austin Rumble Court
King City, Ontario
Canada, L7B 0B2

Equipment Type:

Class A Information Technology Equipment (Including Digital Apparatus)

Product Name:

Universal Gang Programmer

Model :

S-GANG-Iso

**The above product was
tested by UltraTech
Engineering Labs Inc. and
found to comply with:
Date of Authorization:**

ISED Canada ICES-003, Issue 7 - Information Technology Equipment
(Including Digital Apparatus)

January 8, 2025

- Note(s):** See attached report, UltraTech's File No.: 24ELP017_ICE-S003A, dated January 8, 2025 for details and conditions of Verification Compliance.



Approved by: Tri M. Luu
V.P. – Engineering

UltraTech

3000 Bristol Circle, Oakville, Ontario, Canada, L6H 6G4

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CA 0001/2049



ANAB
ANSI National Accreditation Board
ACCREDITED
ISO/IEC 17025
TESTING LABORATORY



SL2-IN-E-1119R



CA0001

ENGINEERING TEST REPORT



Universal Gang Programmer Model No.: S-GANG-Iso

Applicant: **Elprotronic Inc.**
35 Austin Rumble Court
King City, Ontario
Canada, L7B 0B2

Tested in Accordance With
**Innovation, Science and Economic
Development, (ISED) Canada, ICES-003, ISSUE 7,
CLASS A**
**Verification Authorization - Information Technology
Equipment (Including Digital Apparatus)**

UltraTech's File No.: 24ELP017_ICES-003A

This Test report is Issued under the Authority of
Tri M. Luu
Vice President of Engineering
UltraTech Group of Labs

Date: January 8, 2025

Report Prepared by: Phuong Ho

Tested by: Kendrick Luu & Christian Luu

Issued Date: January 8, 2025

Test Dates: September 16 & November 12, 2024

- The results in this Test Report apply only to the sample(s) tested, and the sample tested is randomly selected.
- This report must not be used by the client to claim product endorsement by any agency of the US Government.
- This test report shall not be reproduced, except in full, without a written approval from UltraTech.

UltraTech

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Canada

CA 0001/2049



AT-1945



SL2-IN-E-1119R



CA0001

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EXHIBIT 1. INTRODUCTION

1.1. SCOPE

Reference:	ISED Canada ICES-003, Issue 7
Title	Information Technology Equipment (Including Digital Apparatus)
Purpose of Test:	Verification of Compliance for a Class A Unintentional Radiator.
Test Procedures	Both conducted and radiated emissions measurements were conducted in accordance with American National Standards Institute ANSI C63.4 - American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz and ISED Canada ICES-003, Issue 7
Environmental Classification:	Light-industry, Commercial & Industry

1.2. REVISION HISTORY

Document	Issue Date	Description
24ELP017_ICES-003A	January 8, 2025	Original Document

1.3. RELATED SUBMITTAL(S)/GRANT(S)

None

1.4. NORMATIVE REFERENCES

Publication	Year	Title
ANSI C63.4	2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 KHz to 40 GHz
ICES-003, Issue 7	2020-10	Information Technology Equipment (Including Digital Apparatus)

EXHIBIT 2. PERFORMANCE ASSESSMENT

2.1. CLIENT INFORMATION

APPLICANT/ MANUFACTURER:	
Name:	Elprotronic Inc.
Address:	35 Austin Rumble Court King City, Ontario Canada, L7B 0B2

2.2. EQUIPMENT UNDER TEST (EUT) INFORMATION

The following information (with the exception of the Date of Receipt) has been supplied by the applicant.

Product Name	Universal Gang Programmer
Model Name or Number	S-GANG-Iso
Firmware Version Identification Number :	BS053X01-1.02, CS053X01
Serial Number:	SN: 20240007
CPU Frequencies:	12 MHz, 192 MHz, 480 MHz
Type of Equipment	Information Technology Equipment (Including Digital Apparatus)
Power input source:	6-14 VDC, external AC/DC Adapter
Typical Equipment Usage:	Indoor

2.3. LIST OF ACCESSORIES OF THE EUT

	Name, Make, Model of Component / Part	Short Description of Use
1	S-GANG_Iso	Gang Programmer for MCUs

2.4. LIST OF EUT'S PORTS

Port #	EUT's Port Description	Number of Identical Ports	Connector/ Interface Type	Connected Cabling Length / Type	Cable Type
1	USB-C	1	USB-C	Not allow longer than 3m	Shielded
2	Ethernet	1	Ethernet	Allow longer than 3m	Shielded
3	RS232	1	RS232	Allow longer than 3m	Shielded
4	DC 6-14V	1	DC	Not allow longer than 3m	Non-shielded
5	To Gang Splitter	1	100 pins	Not allow longer than 3m	Non-shielded

2.5. ANCILLARY EQUIPMENT

The EUT was tested while connected to the following representative configuration of ancillary equipment necessary to exercise the ports during tests:

Ancillary Equipment # 1	
Equipment Make and Name:	Gang splitter
Model Name or Number:	S-GANG-SP rev-0
Connected to EUT's Port #: (See above table)	To Gang Splitter

Ancillary Equipment # 2	
Equipment Make and Name:	AC/DC power adapter
Connected to EUT's Port #: (See above table)	DC 6-14V

Ancillary Equipment # 3	
Equipment Make and Name:	PC
Connected to EUT's Port #: (See above table)	USB-C

EXHIBIT 3. EUT OPERATING CONDITIONS AND CONFIGURATIONS DURING TESTS

3.1. CLIMATE TEST CONDITIONS

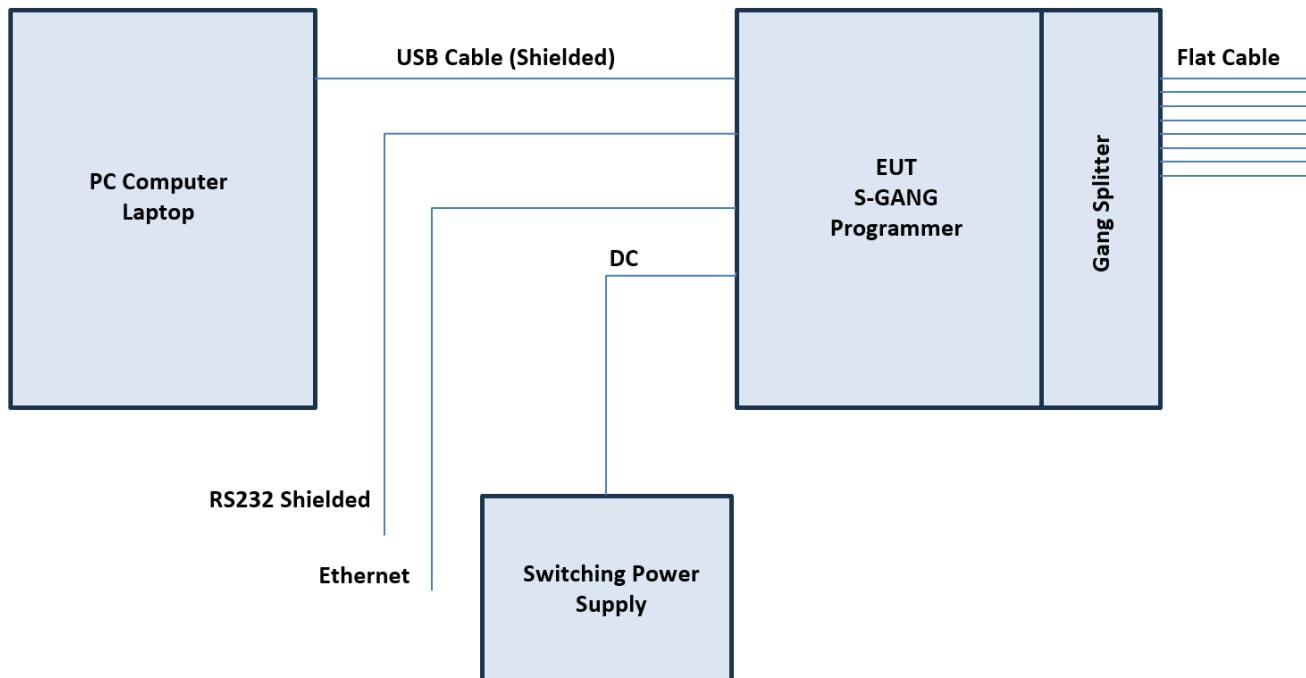
The climate conditions of the test environment are as follows:

Temperature:	24.5°C
Humidity:	30%
Pressure:	100.9 kPa
Power input source:	120 Vac to Adaptor

3.2. OPERATIONAL TEST CONDITIONS & ARRANGEMENT FOR TEST SIGNALS

Connect programmer to external AC/DC adapter (6-14V) and connect programmer via USB cable to PC. Connect target to be programmed via S_GANG_Iso. Run software on PC.

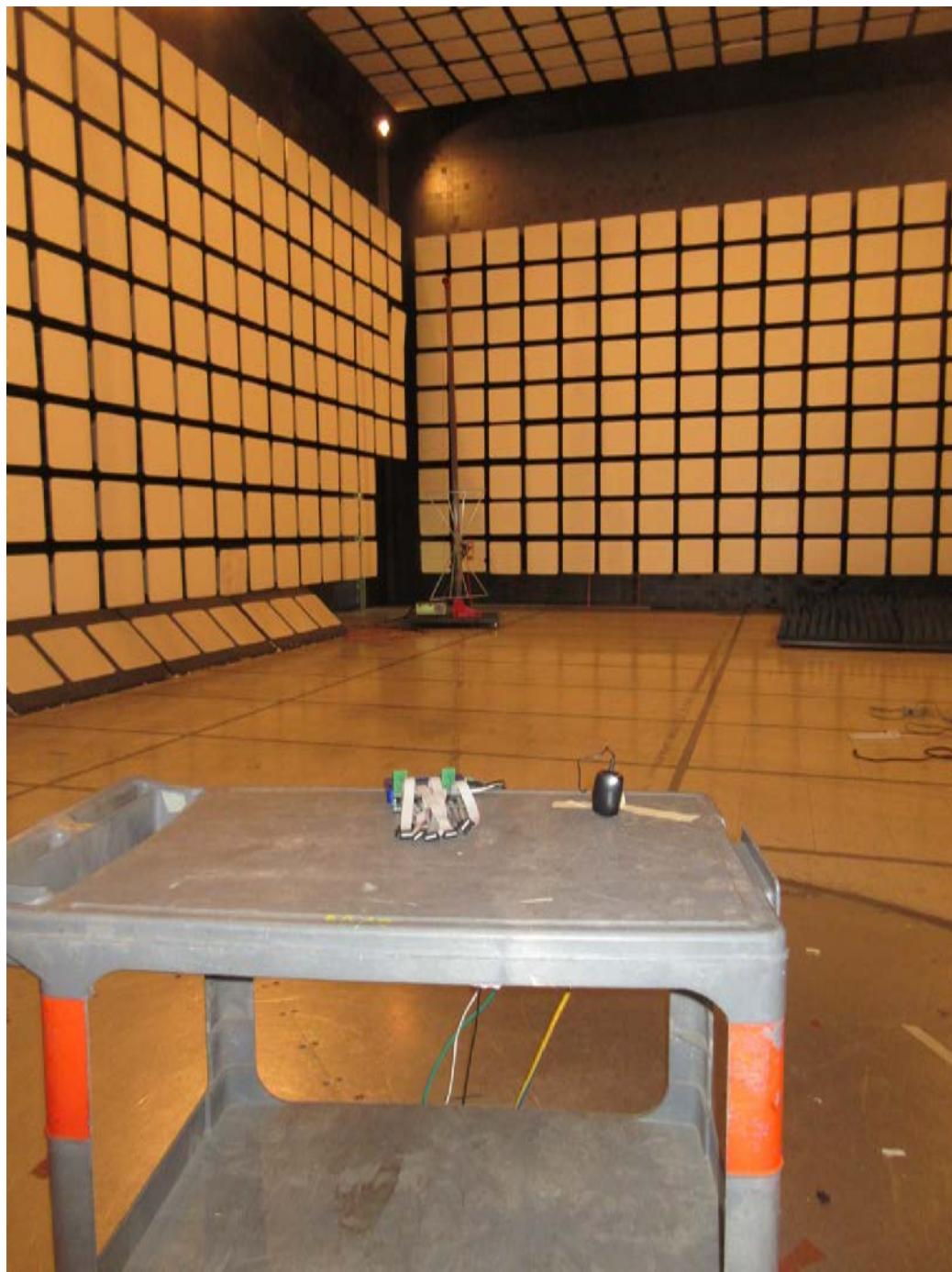
3.3. BLOCK DIAGRAM OF TEST SETUP



3.4. PHOTOGRAPHS OF TEST SETUP FOR AC CONDUCTED EMISSIONS



3.5. PHOTOGRAPHS OF TEST SETUP FOR RADIATED EMISSION MEASUREMENTS



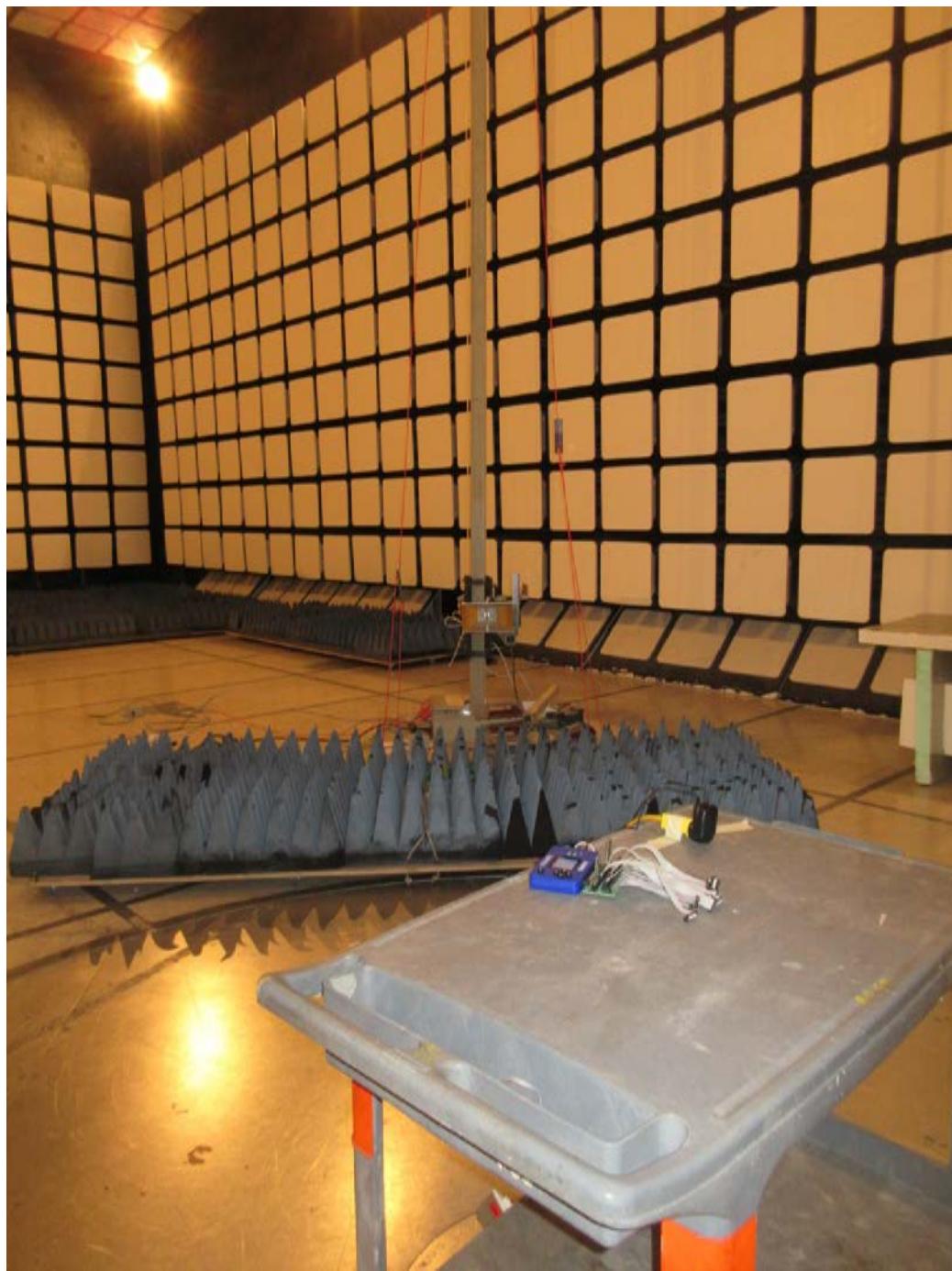


EXHIBIT 4. SUMMARY OF TEST RESULTS

4.1. LOCATION OF TESTS

All of the measurements described in this report were performed at Ultratech Group of Labs located in the city of Oakville, Province of Ontario, Canada.

- AC Powerline Conducted Emissions were performed in UltraTech's shielded room, 24'(L) by 16'(W) by 8'(H).
- Radiated Emissions were performed at the Ultratech's 3-10 TDK Semi-Anechoic Chamber situated in the Town of Oakville, province of Ontario. This test site been calibrated in accordance with ANSI C63.4, and found to be in compliance with the requirements of Sec. 2.948 of the FCC Rules. The descriptions and site measurement data of the Oakville 3-10 TDK Semi-Anechoic Chamber has been filed with ANAB File No.: AT-1945.

4.2. APPLICABILITY & SUMMARY OF EMC EMISSION TEST RESULTS

ICES-003, Issue 7	TEST REQUIREMENTS	MARGIN BELOW (-) / ABOVE (+) THE LIMITS	COMPLAINECE (YES/NO)
Class B Table 2	AC Power Line Conducted Emissions Measurements	- 26.7 dB @ 23.132MHz	Yes
Class B Table 2 & 4	Radiated Emissions from Computing Devices (Digital Devices)	- 5.9 dB @ 57.98 MHz	Yes

4.3. MODIFICATIONS REQUIRED FOR COMPLIANCE

None

EXHIBIT 5. MEASUREMENT DATA

5.1. AC POWERLINE CONDUCTED EMISSIONS

5.1.1. Limits

The equipment shall meet the limits of the following table:

Frequency (MHz)	Limits (dB μ V/m)	
	Quasi-Peak	Average
0.15-0.5	79	66
0.5-5.0	73	60
5.0-30	73	60

5.1.2. Method of Measurements

Refer to Ultratech Test Procedures ULTR-P001-2004 & ANSI C63.4 for method of measurements.

Calculation of Conducted Emission Voltage (dB μ V):

This is calculated by adding the L.I.S.N factor, Cable loss factor, and Attenuator factor to the measured reading. The basic equation with a sample calculation is as follows:

$$\text{Voltage (dB}\mu\text{V)} = \text{RA} + \text{AF} + \text{CF} + \text{LF}$$

Where

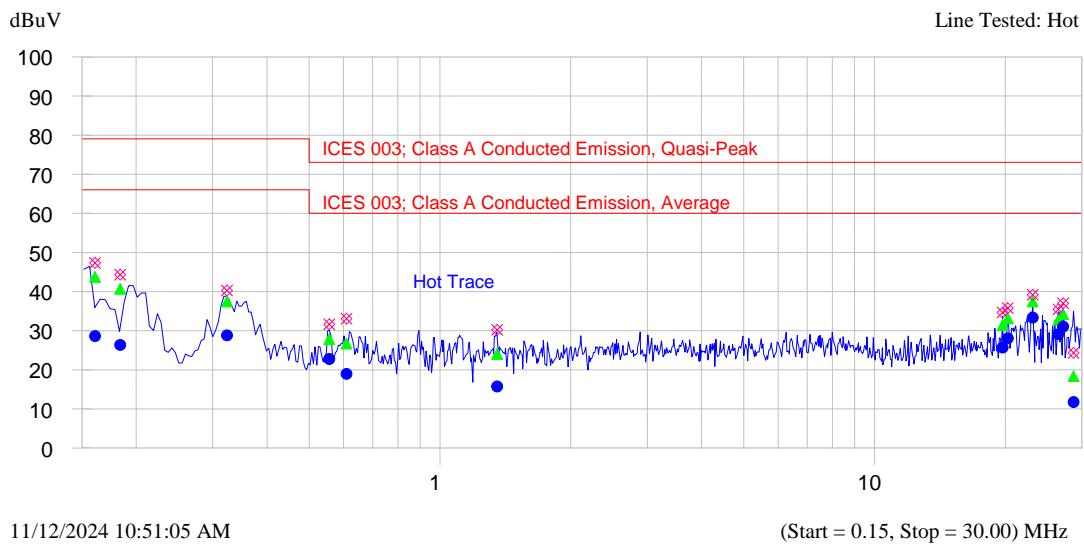
RA = Receiver/Analyzer Reading in dB μ V
AF = Attenuation Factor in dB
CF = Cable loss Factor in dB
LF = L.I.S.N Factor in dB

5.1.3. Test Instruments

Refer to Exhibit 6 for Test Instruments & Measurement Uncertainty.

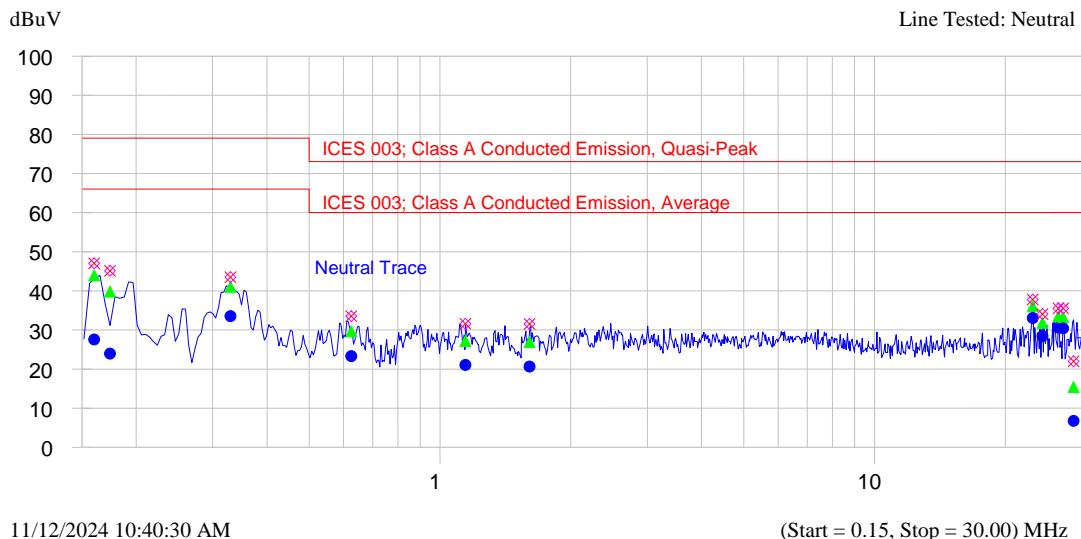
5.1.4. Test Results

Description: Line Voltage: 120Vac,
 Mode Tested: H pattern
 Customer Name: Elprotronics
 Project Number: ELP-017Q
 Operator Name: Kendrick
 EUT Name: Universal Gang Programmer, M/N: S-GANG-Iso



Frequency MHz	Peak dBuV	QP dBuV	QP-QP Limit dB	Avg dBuV	Avg-Avg Limit dB	Trace Name
0.161	47.3	43.7	-35.3	28.6	-37.4	Hot Trace
0.184	44.3	40.7	-38.3	26.3	-39.7	Hot Trace
0.324	40.2	37.5	-41.5	28.8	-37.2	Hot Trace
0.557	31.6	27.8	-45.2	22.7	-37.3	Hot Trace
0.610	33.0	26.7	-46.3	18.9	-41.1	Hot Trace
1.355	30.2	24.0	-49.0	15.7	-44.3	Hot Trace
19.712	34.6	31.4	-41.6	25.7	-34.3	Hot Trace
20.260	35.7	33.2	-39.8	28.0	-32.0	Hot Trace
23.132	39.1	37.5	-35.5	33.3	-26.7	Hot Trace
26.491	35.4	32.8	-40.2	29.1	-30.9	Hot Trace
27.161	37.0	34.3	-38.7	31.0	-29.0	Hot Trace
28.697	24.3	18.4	-54.6	11.7	-48.3	Hot Trace

Description: Line Voltage:120Vac,
 Mode Tested: H pattern
 Customer Name: Elprotronics
 Project Number: ELP-017Q
 Operator Name: Kendrick
 EUT Name: Universal Gang Programmer, M/N: S-GANG-Iso



Frequency MHz	Peak dBuV	QP dBuV	QP-QP Limit dB	Avg dBuV	Avg-Avg Limit dB	Trace Name
0.160	47.0	43.9	-35.1	27.6	-38.4	Neutral Trace
0.174	45.1	39.8	-39.2	23.9	-42.1	Neutral Trace
0.330	43.5	41.0	-38.0	33.5	-32.5	Neutral Trace
0.625	33.5	29.6	-43.4	23.3	-36.7	Neutral Trace
1.144	31.6	27.2	-45.8	21.0	-39.0	Neutral Trace
1.608	31.5	27.0	-46.0	20.6	-39.4	Neutral Trace
23.131	37.7	36.0	-37.0	33.0	-27.0	Neutral Trace
24.353	34.0	31.8	-41.2	28.4	-31.6	Neutral Trace
26.490	35.5	33.5	-39.5	30.6	-29.4	Neutral Trace
27.160	35.5	33.2	-39.8	30.4	-29.6	Neutral Trace
28.703	21.9	15.4	-57.6	6.7	-53.3	Neutral Trace

5.2. RADIATED EMISSIONS

5.2.1. Limits

The equipment shall meet the limits of the following table:

Test Frequency Range (MHz)	Class A Limits (dB μ V/m)	EMI Detector Used	Measurement Distance (meters)
30 – 88	40.0	Quasi-Peak	10
88 – 216	43.5	Quasi-Peak	10
216 – 230	46.4	Quasi-Peak	10
230 – 960	47.0	Quasi-Peak	10
960 – 1000	49.5	Quasi-Peak	10
Above 1000	60.0 80.0	Average Peak	3

Note: The limits above 1 GHz have been extrapolated to 3m as per section 3.2.2 of the standard.

5.2.2. Method of Measurements

Refer to Ultratech Test Procedures ULTR-P001-2004 & ANSI C63.4 for method of measurements.

The spectrum shall be investigated from the lowest radio frequency signal generated or used in the device, without going below the lowest frequency for which a radiated emission limit is specified, up to the frequency shown in the following table:

Highest frequency generated or used in the device (MHz)	Upper frequency of measurement range (MHz)
Below 1.705	No radiated tests required
1.705 – 108	1000
108 – 500	2000
500 -1000	5000
Above 1000	5 th harmonic of the highest frequency or 40 GHz, whichever is lower

Calculation of Field Strength:

The field strength is calculated by adding the calibrated antenna factor and cable factor, and subtracting the Amplifier gain (if any) from the measured reading. The basic equation with a sample calculation is as follows:

$$FS = RA + AF + CF - AG$$

Where FS = Field Strength
RA = Receiver/Analyzer Reading
AF = Antenna Factor
CF = Cable Attenuation Factor
AG = Amplifier Gain

5.2.3. Test Instruments

Refer to Exhibit 6 for Test Instruments & Measurement Uncertainty.

5.2.4. Test Results

Mode tested: H Pattern

The emissions were scanned from 30 to 1000 MHz at 10 Meters distance and all emissions below the limits were recorded.						
FREQUENCY (MHz)	RF LEVEL (dBuV/m)	DETECTOR USED (PEAK/QP)	ANTENNA PLANE (H/V)	LIMIT (dBuV/m)	MARGIN (dB)	PASS/FAIL
57.98	33.1	QP	V	39.0	-5.9	PASS
119.67	26.07	PEAK	H	43.5	-17.4	PASS
132.59	33.7	PEAK	V	43.5	-9.8	PASS
193.22	28.7	PEAK	V	43.5	-14.8	PASS
193.22	30.8	PEAK	H	43.5	-12.7	PASS
218.09	28.76	PEAK	V	46.4	-17.6	PASS
288.04	38.2	PEAK	V	46.4	-8.2	PASS
288.04	36.36	PEAK	H	46.4	-10.0	PASS
479.24	28.23	PEAK	V	46.4	-18.2	PASS
560.08	34.57	PEAK	V	46.4	-11.8	PASS
560.08	33.43	PEAK	H	46.4	-13.0	PASS
598.94	31.73	PEAK	V	46.4	-14.7	PASS
640.91	38.89	PEAK	V	46.4	-7.5	PASS
640.91	33.82	PEAK	H	46.4	-12.6	PASS
678.22	35.76	PEAK	V	46.4	-10.6	PASS
678.22	35.4	PEAK	H	46.4	-11.0	PASS
710.86	38.9	QP	V	46.4	-7.5	PASS
719.71	34.08	PEAK	H	46.4	-12.3	PASS
762.16	34.67	PEAK	V	46.4	-11.7	PASS
801.02	34.97	PEAK	V	46.4	-11.4	PASS

Note: The limits in the table below are the FCC Part 15, Class B limits as they are more stringent than the ICES-003 limits.

EXHIBIT 6. TEST INSTRUMENTS & MEASUREMENT UNCERTAINTY

6.1. MEASUREMENT UNCERTAINTY

The measurement uncertainties stated are calculated in accordance with the requirements of CISPR 16-4-2 @ IEC:2003 and JCGM 100:2008 (GUM 1995) – Guide to the Expression of Uncertainty in Measurement.

Expanded uncertainty is stated as standard uncertainty multiplied by coverage factor, $k=2$ for a 95% Confidence level.

6.2. MEASUREMENT UNCERTAINTY

Test description	U_{LAB} (dB)	U_{CISPR} (dB)
Power Line Conducted Emission Uncertainty(150 KHz – 30 MHz)	± 2.62	± 3.4
Radiated Emissions Measurement Uncertainty (30-1000 MHz)	± 4.82	± 6.3
Radiated Emissions Measurement Uncertainty (above 1 GHz)	± 3.43	± 5.2

6.3. TEST EQUIPMENT LIST

6.3.1. Line Conducted Emissions

Test Instruments	Manufacturer	Model No.	Serial No.	Cal Due Date
EMI Analyzer	Agilent	8593EM	3710A00223	May-9-2025
LISN	EMCO	3825/2	8907-1531	Mar-6-2025
Attenuator	Rohde & Schwarz	EZ-25	100064	Nov-9-2025

Test Software: Agilent (HP) E7415A EMI Test Measurement Software, version A.01.40 is used for automated measurement.

Test Date: Nov. 12, 2024

6.3.2. Radiated Emissions

Test Instruments	Manufacturer	Model No.	Serial No.	Freq. Range	Cal Due Date
EMI Receiver	Rohde & Schwarz	ESU40	100037	20 Hz to 40 GHz	21-Sep-24
Biconilog Antenna	EMCO	3142C	34792	26 – 3000 MHz	16-Dec-25
Pre-Amplifier	Com-Power	PAM-118A	550152	500 MHz to 18 GHz	07-Oct-25
Horn Antenna	EMCO	3115	5955	1GHz – 18 GHz	4-Nov-24

Test Date: Sept. 16, 2024

** END OF REPORT **